IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Nobuo NAITO et al.

Application No.: New U.S. National Stage of PCT/JP2005/000644

Filed: May 23, 2006 Docket No.: 128132

For: ELECTROMAGNETIC WAVE SHIELDING FILM AND METHOD FOR PRODUCING

THE SAME

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450. Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. Relevance of one or more non-English language reference is discussed in the present specification. See References 9-11.
- 3. One or more reference cited herein was cited in the International Search Report. An English language version of the International Search Report is attached for the Examiner's information. See References 1-8.
- 4. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- 5. An English language Abstract of one or more non-English language reference is attached hereto. See References 4-11.
- 6. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([http://www.jpo.go.jp]), and is attached, but has not been reviewed for accuracy. See References 4-11.

New U.S. National Stage of PCT/JP2005/000644 APS REC'S PCT/FTO 23 MAY 2005

 \boxtimes 7. Reference $\underline{4}$ corresponds to reference $\underline{1}$. References $\underline{5-6}$ correspond to reference

 $\underline{2}$. Reference $\underline{8}$ corresponds to reference $\underline{3}$.

Respectfully submitted,

James A. Oliff

Registration No. 27,075

Daniel A. Tanner, III Registration No. 54,734

JAO:DAT/nxy

Date: May 23, 2006

OLIFF & BERRIDGE, PLC P.O. Box 19928 Alexandria, Virginia 22320 Telephone: (703) 836-6400 DEPOSIT ACCOUNT USE
AUTHORIZATION
Please grant any extension
necessary for entry;
Charge any fee due to our
Deposit Account No. 15-0461

10/580414 IAP9 Rec'd PCT/PTO 23 MAY 2006

Sheet 1 of 1 Form PTO-1449 US Dept. of Commerce ATTY DOCKET NO. APPLICATION NO. PATENT & TRADEMARK OFFICE 128132 New U.S. National (REV. 1/06) Stage of INFORMATION DISCLOSURE STATEMENT PCT/JP2005/000644 (Use several sheets if necessary) **APPLICANTS** Nobuo NAITO et al. FILING DATE May 23, 2006 U.S. PATENT DOCUMENTS Cite Examiner Document Number Date Name Initials No. 2003/0164243 A1 09/04/2003 ARAKAWA et al. 1. SHIMAMURA et al. 2. 2003/0007341 A1 01/09/2003 05/22/2003 KOJIMA et al. 2003/0094296 A1 3. FOREIGN PATENT DOCUMENTS With With Examiner Cite English Document Number Date Country English Initials No. Abstract Translation JP-A-2003-318596 11/07/2003 **JAPAN** Х Х 4. Х Х 09/12/2003 **JAPAN** 5. JP-A-2003-258488 12/04/2002 **JAPAN** \mathbf{X} X JP-A-2002-347166 6. 7. JP-A-2003-037388 02/07/2003 **JAPAN** Х Х 8. JP-A-2003-086991 03/20/2003 **JAPAN** X X 01/14/2000 Х Х JP-A-2000-013088 **JAPAN** 9. JP-A-2000-059079 02/25/2000 **JAPAN** Х Х 10. Х Х 11. JP-A-2002-009484 01/11/2002 **JAPAN** OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) Cite Examiner Initials No. DATE CONSIDERED **EXAMINER** Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance

and not considered. Include copy of this form with next communication to applicant.

Date: May 23, 2006

Examiner: